

Radiation testing campaign results for understanding the suitability of FPGAs in detector electronics.



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The use of a **Field Programmable Gate Array (FPGA)** in high energy physics experiments is only limited by our ability to **mitigate single event effects** induced by the high energy hadrons present in the radiation field.

Radiation induced failures on electronics are tested in facilities:

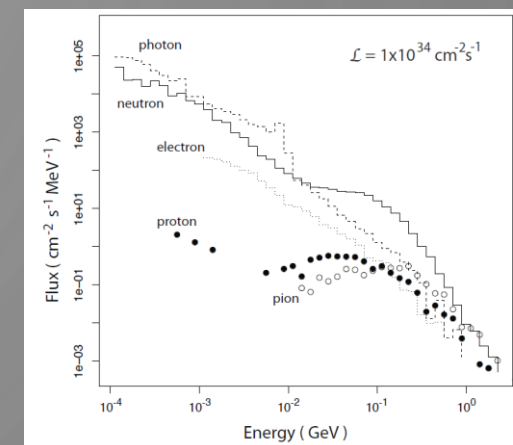
- With particle energy spectra similar to the expected High Energy Physics (HEP) environment
- At high rates to find single event effects with small cross sections

Electronic devices will be affected by:

- Single Event effects
- Total ionizing dose
- Displacement damage

	Simulation (one year)	Safety Factor	Test Target* (10 years)
Ionizing Dose	3.0 rad	10	100 krad
1 MeV eq. Neutron	$6.0 \times 10^{11} \text{ cm}^{-2}$	2	$1.2 \times 10^{13} \text{ cm}^{-2}$
Hadrons (>20 MeV)	$8.5 \times 10^{10} \text{ cm}^{-2}$	2	$2 \times 10^{12} \text{ cm}^{-2}$

*1 LHC year = 10^7 s , $\sigma_{pp} = 80 \text{ mb}$, Luminosity = $5 \times 10^{34} \text{ cm}^{-2}\text{s}^{-1}$



Xilinx Kintex 7 performance tested under irradiation

Rad-hard techniques must prevent:

- Build up of configuration errors in CRAM
- Errors that “breaks” SEC/DED code in BRAM
- Corruption on transmitted data
- Transmitter/receiver de-synchronization



FPGA sensitive to Single Event Upset (SEU)

Mitigation

Triple Modular Redundancy (TMR)

Scrubbing

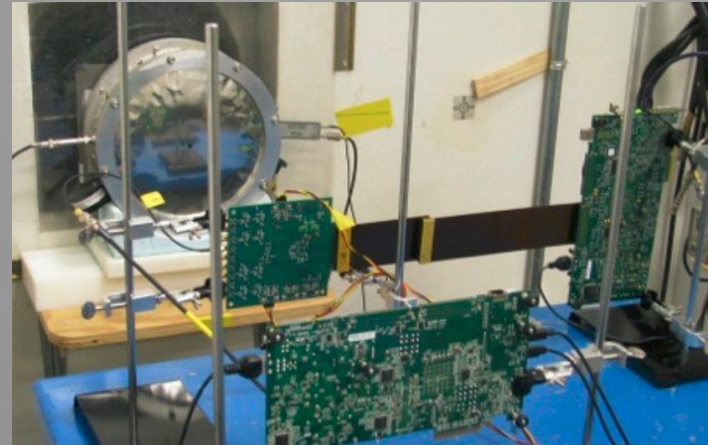
H4IRRAD, CERN:

- **mixed-field (hadrons and neutrons)**
 - **CRAM and BRAM cross section** measurements



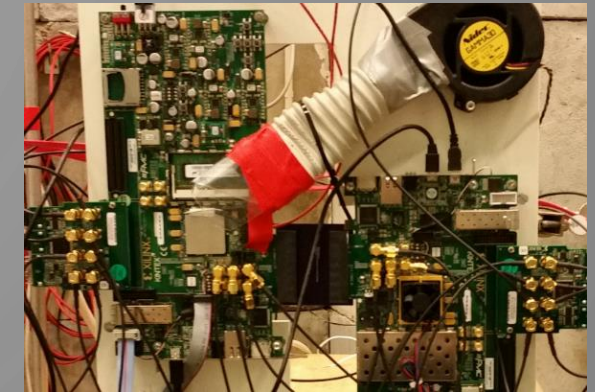
LANSCE - WNR (Los Alamos):

- **neutrons (max energy 800 MeV), wide spectrum similar to cosmic ray background**
 - **CRAM and BRAM cross section** measurements



The Svedberg Laboratory (TSL), Sweden:

- **neutrons (max energy 200 MeV)**
 - **CRAM and BRAM cross section** measurements
- **180 MeV protons**
 - **CRAM and BRAM cross section** measurements
 - performance of the **GTX transceivers**



Cross section comparison

	CRAM (cm ² /bit)	BRAM (cm ² /bit)	Fluence (particle/cm ²)
H4IRRAD - Hadron	1.50 x 10 ⁻¹⁴	1.40 x 10 ⁻¹⁴	1.8 x 10 ⁹
LANSCE - Neutron	6.89 x 10 ⁻¹⁵	6.15 x 10 ⁻¹⁵	5.7 x 10 ¹⁰
TSL - Neutron	6.55 x 10 ⁻¹⁵	-	>5.7 x 10 ¹⁰
TSL - Proton	8.29 x 10 ⁻¹⁵	8.19 x 10 ⁻¹⁵	1.3 x 10 ¹³

CONCLUSION AND OUTLOOK

- **No permanent operational failures** observed
- **TMR plus multi-level scrubbing** essential to mitigate SEU in Kintex 7 FPGAs.
- In the full scale **ATLAS** LAr calorimeter system we could estimate **a lane failure every 6.5 minutes.**

Future experiments are planned with improved TMR and scrubbing mitigation strategies to further reduce the present error rates.